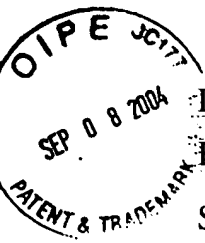


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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE



In re Patent Application of

KOCHERGIN

Serial No. 10/774,687

Filed: 10 February 2004

Atty. Ref.: 340-88

TC/A.U.: 2873

Examiner:

For: MAGNETIC FIELD AND ELECTRICAL CURRENT
VISUALIZATION SYSTEM

* * * * *

September 8, 2004

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

INFORMATION DISCLOSURE STATEMENT

In accordance with Rule 97, the undersigned attorney submits the documents listed on the attached form PTO-1449. A copy of each non-U.S. patent document is enclosed.

Applicant requests the Examiner to initial the attached form PTO-1449 and to return a copy to the undersigned as an indication that the attached documents have been considered and made of record in this case.

Respectfully submitted,

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INFORMATION DISCLOSURE
CITATION

ATTY. DOCKET NO.

SERIAL NO.

340-88

10/774,687

APPLICANT

KOCHERGIN

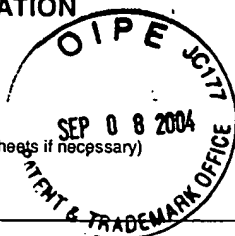
FILING DATE

TC/A.U.

10 February 2004

2873

(Use several sheets if necessary)



U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,625,167	11/1986	Fitzpatrick			
	5,894,220	04/1999	Wellstood et al.			
	5,583,690	12/1996	Andrae et al.			
	5,969,517	10/1999	Rao			
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DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
DE 4027049	03/1991	Germany			X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

*	B. Ludescher, et al., "Faraday Low-temperature Microscope for observing Dynamic Magnetization processes in Superconductors" (i.e., Faraday-Tieftemperatur-Mikroskop zur Beobachtung dynamischer Magnetisierungsvorgänge in Supraeitern), <i>Laser und Optoelektronik</i> 23 (1991), pages 54-58
	L.A. Dorosinskii, et al., "Studies of HTSC crystal magnetization features using indicator magnetooptic films with in-plane anisotropy," <i>Physica C</i> 203 (1992), pp 149-156
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	Klank, M. et al., "Sensitive magneto-optical sensors for visualization of magnetic fields using garnet films of specific orientations," <i>J. of Appl. Phys.</i> , 92 (11), pp. 6484-6488, Dec 2002.

*document not available

*Examiner

Date Considered

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.